

L Number	Hits	Search Text	DB	Time stamp
1	850	"I4" and 714/(736-738).ccls. and (location with vector) and compare	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/22 07:07
2	61534	(fault error short) and ((integrated adj circuit) or IC or chip or wafer) and (vector signal pattern) and compare	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/22 07:07
3	165744	(fault error short) and ((integrated adj circuit) or IC or chip or wafer) and (vector signal pattern) and (compare compared comparing comparison)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/22 07:08
4	78	(fault error short) and ((integrated adj circuit) or IC or chip or wafer) and (vector signal pattern) and (compare compared comparing comparison) and 714/819.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/22 10:07
5	24945	(fault error short) and ((integrated adj circuit) or IC or chip or wafer) and (vector signal pattern) and (compare compared comparing comparison) and 324/(522-523).ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/22 10:07
6	24945	(fault error short) and ((integrated adj circuit) or IC or chip or wafer) and (vector signal pattern) and (compare compared comparing comparison) and 324/(522-523).ccls. and (NRZ or (return near2 zero))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/22 10:10
7	325379	324/(522-523).ccls. and (NRZ or (return near2 zero))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/22 10:09
9	0	324/523.ccls. and (NRZ or (return near2 zero))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/22 10:10
10	1	(fault error short) and ((integrated adj circuit) or IC or chip or wafer) and (vector signal pattern) and (compare compared comparing comparison) and 324/522.ccls. and (NRZ or (return near2 zero))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/22 10:10
8	5	324/522.ccls. and (NRZ or (return near2 zero))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/22 10:11

20	5	4309657.URPN.	USPAT	2004/01/22 13:40
-	2	6526546.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 17:48
-	82	desplats.in.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 15:30
-	9	desplats.in. and perdu.in.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 15:30

-	103	("5274264" "5375126" "5481548" "5498964" "5528748" "5600788" "5696451" "6070252" "4309657" "4395767" "4487121" "4820991" "4872168" "4967151" "5222066" "5299136" "5406565" "5425035" "5537632" "5570376" "5668815" "5673028" "5696788" "5862151" "5892539" "5982681" "6041390" "6096093" "4625310" "4871257" "6219808" "6219808" "6239604" "4862399" "5276400" "5420522" "5422891" "5465053" "5515383" "5633812" "5726997" "6148425" "4423509" "4438494" "4463450" "4481627" "4542509" "4554661" "4556840" "4594711").pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 17:49
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-	49	("5274264" "5375126" "5481548" "5498964" "5528748" "5600788" "5696451" "6070252" "4309657" "4395767" "4487121" "4820991" "4872168" "4967151" "5222066" "5299136" "5406565" "5425035" "5537632" "5570376" "5668815" "5673028" "5696788" "5862151" "5892539" "5982681" "6041390" "6096093" "4625310" "4871257" "6219808" "6219808" "6239604" "4862399" "5276400" "5420522" "5422891" "5465053" "5515383" "5633812" "5726997" "6148425" "4423509" "4438494" "4463450" "4481627" "4542509" "4554661" "4556840" "4594711").pn.	USPAT; US-PGPUB	2004/01/21 18:04
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-	327102	(fault error short) and ((integrated adj circuit) or IC or chip or wafer)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 18:06
-	251560	(fault error short) and ((integrated adj circuit) or IC or chip or wafer) and (vector signal pattern)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 19:10
-	99370	(fault error short) and ((integrated adj circuit) or IC or chip or wafer) and (vector signal pattern) and sequence	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 19:31
-	121	(fault error short) and ((integrated adj circuit) or IC or chip or wafer) and (vector signal pattern) and sequence and IDDQ	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 18:20
-	124	(fault error short) and ((integrated adj circuit) or IC or chip or wafer or circuit) and (vector signal pattern) and sequence and IDDQ	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 18:21
-	853	location adj vector	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 19:11
-	186	IDDQ with (measure monitor measured measuring monitored monitoring)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 19:12
-	12586	location with vector	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 19:11
-	2	(IDDQ with (measure monitor measured measuring monitored monitoring)) and (location with vector)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 19:11
-	232	IDDQ with (measure monitor measured measuring monitored value monitoring)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 19:12

-	6	(IDDQ with (measure monitor measured measuring monitored value monitoring)) and (location with vector)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 19:25
-	21252	((fault error short) and ((integrated adj circuit) or IC or chip or wafer)) and 714/(736-738).ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 19:26
-	19854	((fault error short) and ((integrated adj circuit) or IC or chip or wafer) and (vector signal pattern)) and 714/(736-738).ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 19:29
-	19854	((fault error short) and ((integrated adj circuit) or IC or chip or wafer) and (vector signal pattern)) and 714/(736-738).ccls. and (location with vector)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/01/21 19:30